

RoHS

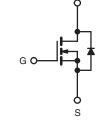
COMPLIANT

Power MOSFET

| PRODUCT SUMMARY | | | | | |
|----------------------------|-----------------|------|--|--|--|
| V _{DS} (V) | 500 | | | | |
| R _{DS(on)} (Ω) | $V_{GS} = 10 V$ | 0.40 | | | |
| Q _g (Max.) (nC) | 74 | | | | |
| Q _{gs} (nC) | 19 | | | | |
| Q _{gd} (nC) | 35 | | | | |
| Configuration | Single | | | | |







N-Channel MOSFET

FEATURES

- · Ultra Low Gate Charge
- Reduced Gate Drive Requirement
- Enhanced 30 V V_{GS} Rating
- Reduced C_{iss}, C_{oss}, C_{rss}
- Isolated Central Mounting Hole
- Dynamic dV/dt Rated
- · Repetitive Avalanche Rated
- · Lead (Pb)-free Available

DESCRIPTION

This new series of low charge Power MOSFETs achieve significantly lower gate charge over conventional MOSFETs. Utilizing advanced Power MOSFET technology the device improvements allow for reduced gate drive requirements, faster switching speeds and increased total system savings. These device improvements combined with the proven ruggedness and reliability of Power MOSFETs offer the designer a new standard in power transistors for switching applications.

The TO-247 package is preferred for commercial-industrial applications where higher power levels preclude the use of TO-220 devices. The TO-247 is similar but superior to the earlier TO-218 package because of its isolated mounting hole.

| ORDERING INFORMATION | |
|----------------------|---------------|
| Package | TO-247 |
| Lead (Pb)-free | IRFP450LCPbF |
| | SiHFP450LC-E3 |
| SnPb | IRFP450LC |
| | SiHFP450LC |

| ABSOLUTE MAXIMUM RATINGS \ensuremath{T} | _C = 25 °C, u | nless otherw | ise noted | | | |
|--|--|-------------------------|-----------------------------------|---------------|----------|--|
| PARAMETER | | | SYMBOL | LIMIT | UNIT | |
| Drain-Source Voltage | | | V _{DS} | 500 | v | |
| Gate-Source Voltage | | | V _{GS} | ± 30 | | |
| Continuous Drain Current | V_{GS} at 10 V $T_C = 25 \degree C$ $T_C = 100 \degree C$ | | 14 | | | |
| | VGS at 10 V | T _C = 100 °C | ID | 8.6 | А | |
| Pulsed Drain Current ^a | | | I _{DM} | 56 | 1 | |
| Linear Derating Factor | | | | 1.5 | W/°C | |
| Single Pulse Avalanche Energy ^b | | | E _{AS} | 760 | mJ | |
| Repetitive Avalanche Current ^a | | | I _{AR} | 14 | A | |
| Repetitive Avalanche Energy ^a | | | E _{AR} | 19 | mJ | |
| Maximum Power Dissipation | T _C = | 25 °C | P _D 190 | | W | |
| Peak Diode Recovery dV/dt ^c | 1 | | dV/dt | 3.5 | V/ns | |
| Operating Junction and Storage Temperature Range | | | T _J , T _{stg} | - 55 to + 150 | °C | |
| Soldering Recommendations (Peak Temperature) | | | 300 ^d | | | |
| Mounting Torque | 6-32 or M3 screw | | | 10 | lbf ⋅ in | |
| | | | | 1.1 | N · m | |

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. $V_{DD} = 25 \text{ V}$, starting $T_J = 25 \text{ °C}$, L = 7.0 mH, $R_G = 25 \Omega$, $I_{AS} = 14 \text{ A}$ (see fig. 12). c. $I_{SD} \le 14 \text{ A}$, dl/dt $\le 130 \text{ A/}\mu\text{s}$, $V_{DD} \le V_{DS}$, $T_J \le 150 \text{ °C}$.

d. 1.6 mm from case.

* Pb containing terminations are not RoHS compliant, exemptions may apply



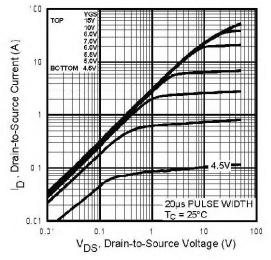
| THERMAL RESISTANCE RA | TINGS | | | | | | | | |
|---|---------------------|---|--|--------------------|------|-----------|----------|------|--|
| PARAMETER | SYMBOL | TYP. | | MAX. | | UNIT | | | |
| Maximum Junction-to-Ambient | R _{thJA} | - 40 0.24 - | | | °C/W | | | | |
| Case-to-Sink, Flat, Greased Surface | R _{thCS} | | | | | | | | |
| Maximum Junction-to-Case (Drain) | R _{thJC} | - 0.65 | | | 1 | | | | |
| | | | | | | L | | | |
| SPECIFICATIONS T _J = 25 °C, | unless otherv | vise noted | | | | | | | |
| PARAMETER | SYMBOL | TEST | CONDITION | IS | MIN. | TYP. | MAX. | UNIT | |
| Static | | | | | | | | | |
| Drain-Source Breakdown Voltage | V _{DS} | $V_{GS} = 0$ | V, I _D = 250 | μΑ | 500 | - | - | V | |
| V _{DS} Temperature Coefficient | $\Delta V_{DS}/T_J$ | Reference | to 25 °C, I _D | = 1 mA | - | 0.59 | - | V/°C | |
| Gate-Source Threshold Voltage | V _{GS(th)} | $V_{DS} = V_{GS}, I_D = 250 \ \mu A$ | | | 2.0 | - | 4.0 | V | |
| Gate-Source Leakage | I _{GSS} | Ve | _S = ± 20 V | | - | - | ± 100 | nA | |
| | | $V_{DS} = 500 \text{ V}, V_{GS} = 0 \text{ V}$ $V_{DS} = 400 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 125 \text{ °C}$ | | 0 V | - | - | 25 | | |
| Zero Gate Voltage Drain Current | I _{DSS} | | | - | - | 250 | μA | | |
| Drain-Source On-State Resistance | R _{DS(on)} | V _{GS} = 10 V | I _D = | 8.4 A ^b | - | - | 0.40 | Ω | |
| Forward Transconductance | 9 _{fs} | V _{DS} = 5 | 0 V, I _D = 8.4 | ↓ A ^b | 8.7 | - | - | S | |
| Dynamic | | | | | | | • | | |
| Input Capacitance | C _{iss} | l v | _{GS} = 0 V, | | - | 2200 | - | | |
| Output Capacitance | C _{oss} | $V_{GS} = 0.V,$ $V_{DS} = 25 V,$ f = 1.0 MHz, see fig. 5 | | - | 320 | - | pF | | |
| Reverse Transfer Capacitance | C _{rss} | | | - | 28 | - | | | |
| Total Gate Charge | Qg | | | | - | - | 74 | | |
| Gate-Source Charge | Q _{gs} | V _{GS} = 10 V | $V_{GS} = 10 V$ $I_D = 14 A, V_{DS} = 4$ | | - | - | 19 | nC | |
| Gate-Drain Charge | Q _{gd} | $V_{GS} = 10$ V see fig. 6 and 13 ^b | | | - | - | 35 | | |
| Turn-On Delay Time | t _{d(on)} | | | | - | 14 | - | | |
| Rise Time | t _r | Van - 2 | 50 V la – 1 | 4 4 | - | 49 | - | 1 | |
| Turn-Off Delay Time | t _{d(off)} | $V_{DD} = 250 \text{ V}, \text{ I}_D = 14 \text{ A},$ $R_G = 6.2 \Omega, R_D = 17 \Omega$, see fig. 10 ^b | | - | 30 | - | ns | | |
| Fall Time | t _f | 1 | | | - | 30 | - | 1 | |
| Internal Drain Inductance | L _D | Between lead, 6 mm (0.25") from package and center of die contact | | - | 5.0 | - | nH | | |
| Internal Source Inductance | L _S | | | - | 13 | - | | | |
| Drain-Source Body Diode Characteristic | s | | | | | | • | | |
| Continuous Source-Drain Diode Current | ١ _S | MOSFET symbol showing the integral reverse p - n junction diode | | - | - | 14 | A | | |
| Pulsed Diode Forward Current ^a | I _{SM} | | | - | - | 56 | | | |
| Body Diode Voltage | V_{SD} | $T_J = 25 \ ^{\circ}C, \ I_S = 14 \ A, \ V_{GS} = 0 \ V^b$ | | | - | - | 1.4 | V | |
| Body Diode Reverse Recovery Time | t _{rr} | $T_J = 25 \text{ °C}, I_F = 14 \text{ A}, dl/dt = 100 \text{ A}/\mu\text{s}^b$ | | - | 580 | 870 | ns | | |
| Body Diode Reverse Recovery Charge | Q _{rr} | | | - | 5.1 | 7.7 | μC | | |
| Forward Turn-On Time | t _{on} | Intrinsic turn-on time is negligible (turn-on is o | | | | ninotod b | vl - opd | -) | |

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

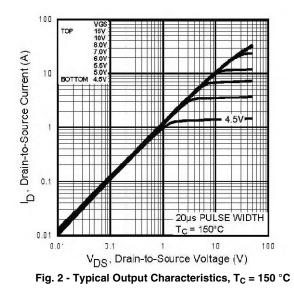
b. Pulse width \leq 300 µs; duty cycle \leq 2 %.





TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

Fig. 1 - Typical Output Characteristics, T_C = 25 °C



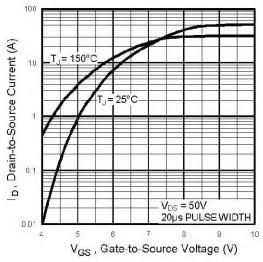
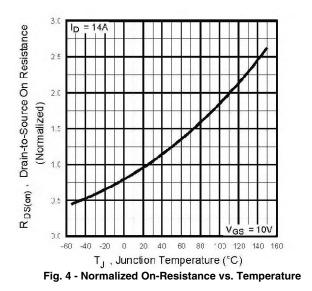


Fig. 3 - Typical Transfer Characteristics



IRFP450LC, SiHFP450LC

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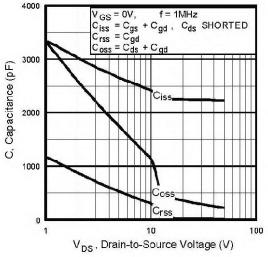


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

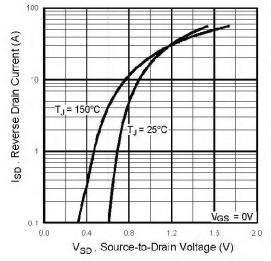


Fig. 7 - Typical Source-Drain Diode Forward Voltage

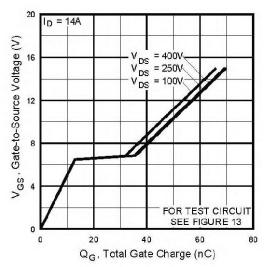
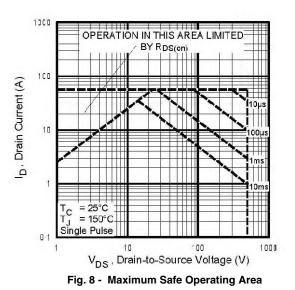


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage





IRFP450LC, SiHFP450LC

Vishay Siliconix

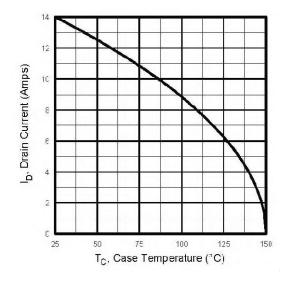


Fig. 9 - Maximum Drain Current vs. Case Temperature

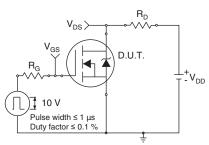


Fig. 10a - Switching Time Test Circuit

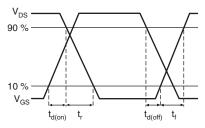
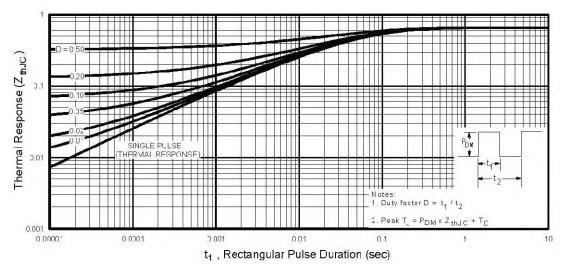
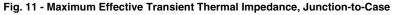


Fig. 10b - Switching Time Waveforms





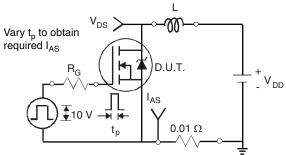


Fig. 12a - Unclamped Inductive Test Circuit

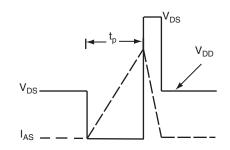


Fig. 12b - Unclamped Inductive Waveforms

IRFP450LC, SiHFP450LC

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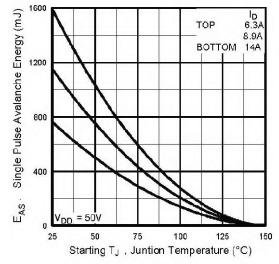


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

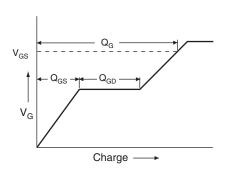
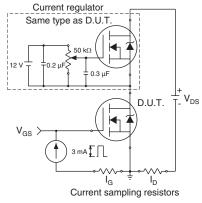
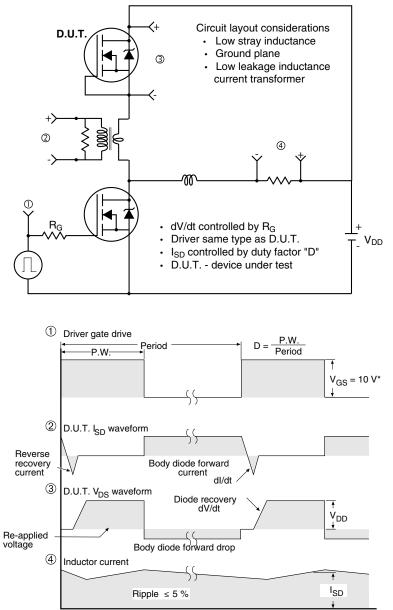


Fig. 13a - Basic Gate Charge Waveform









Peak Diode Recovery dV/dt Test Circuit

* $V_{GS} = 5$ V for logic level devices

Fig. 14 - For N-Channel

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